

2022.04.09



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中国基础教育质量监测协同创新中心
Collaborative Innovation Center of Assessment for
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New Item Selection Designs for Computerized Classification Test

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NCME Annual Conference

- Computerized classification testing (CCT):
 - divide students into different groups (e.g., “pass” or “fail”)

- Maximize Fisher information at the cut score θ_c (MFC):

$$i_k = \operatorname{argmax}_{j \in R_{k-1}} FI_j(\theta_c)$$



high risk of item leaking
long and uneven test-taking time

- Timed-MFC by Sie et al. (2015):

$$i_k = \operatorname{argmax}_{j \in R_{k-1}} \frac{FI_j(\theta_c)}{E(T_j | \hat{t}_{k-1})}$$



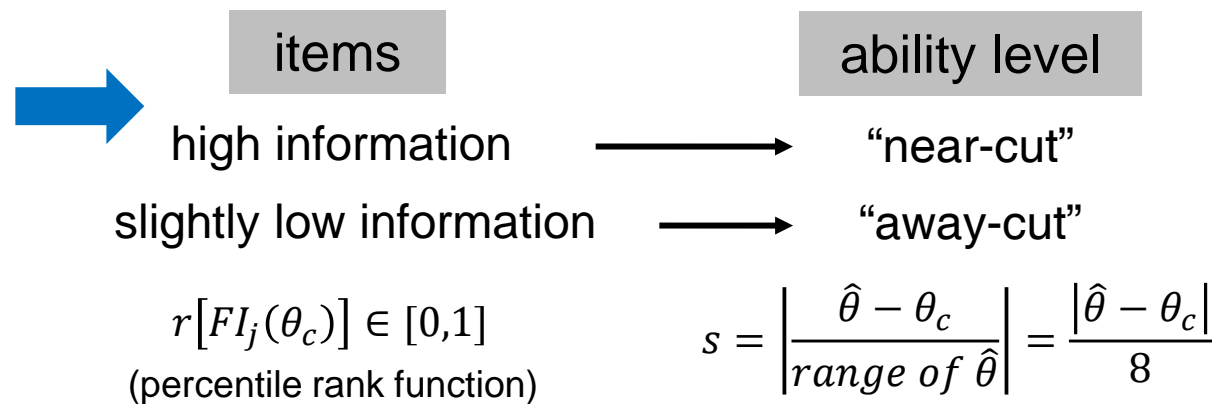
strong preference for the low time density items

Purpose: develop new item selection methods

✓ balanced item bank usage + short and stable test-taking time

What if we relax the compulsory rule? (select the most informative items in all situations)

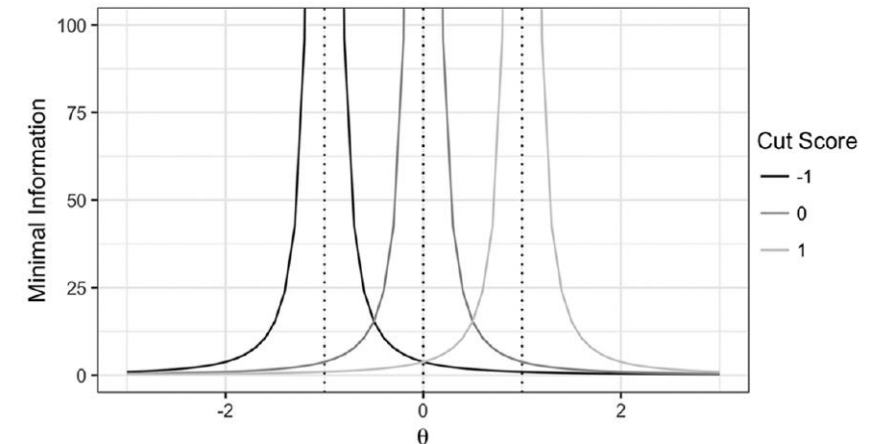
- Stage adaptive item selection method (SAI)



measure the similarity between r and s :

$$SAI = \exp\{-|r[FI_j(\theta_c)] + w \times s - 1|\}$$

↓
(weighting parameter ≥ 0)

$$i_k = \operatorname{argmax}_{j \in R_{k-1}} SAI$$


[Luo et al., 2018 *Applied Psychological Measurement*]


- the “near-cut” positions require more information
- while the “away-cut” positions require less

- Modified timed-MFC: combine the idea proposed by Choe et al. (2018)

$$i_k = \operatorname{argmax}_{j \in R_{k-1}} \frac{FI_j(\theta_c)}{|E(T_j|\hat{t}_{k-1}) - v|}$$

- \hat{t}_{k-1} examinee's speed after $k - 1$ items
- β_j time density of item j
- α_j time discriminating power of item j
- v centering parameter ≥ 0

- from $E(T_j|\hat{t}_{k-1}) \rightarrow 0$ to $E(T_j|\hat{t}_{k-1}) \rightarrow v$


$$E(T_j|\hat{t}_{k-1}) = e^{\beta_j - \tau + 1/(2\alpha_j^2)} = v$$

$$\beta_j + \frac{1}{2\alpha_j^2} = \hat{t}_{k-1} + \ln v$$

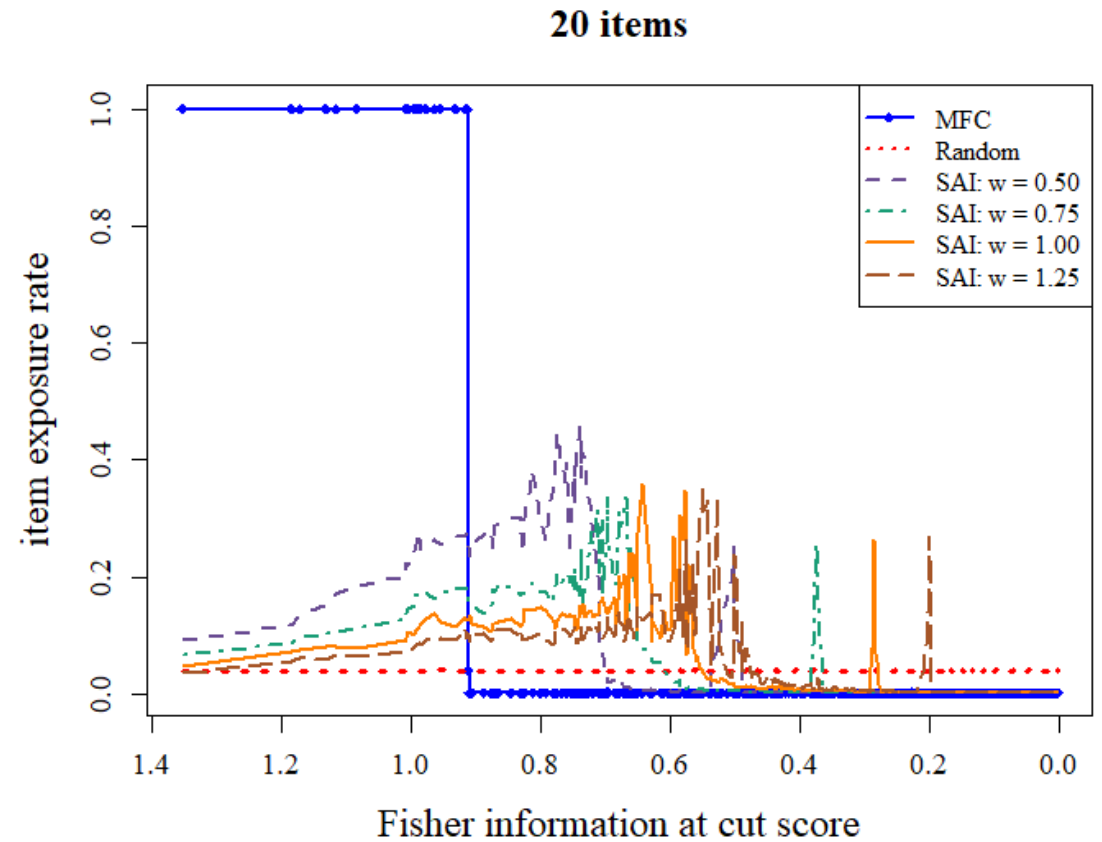
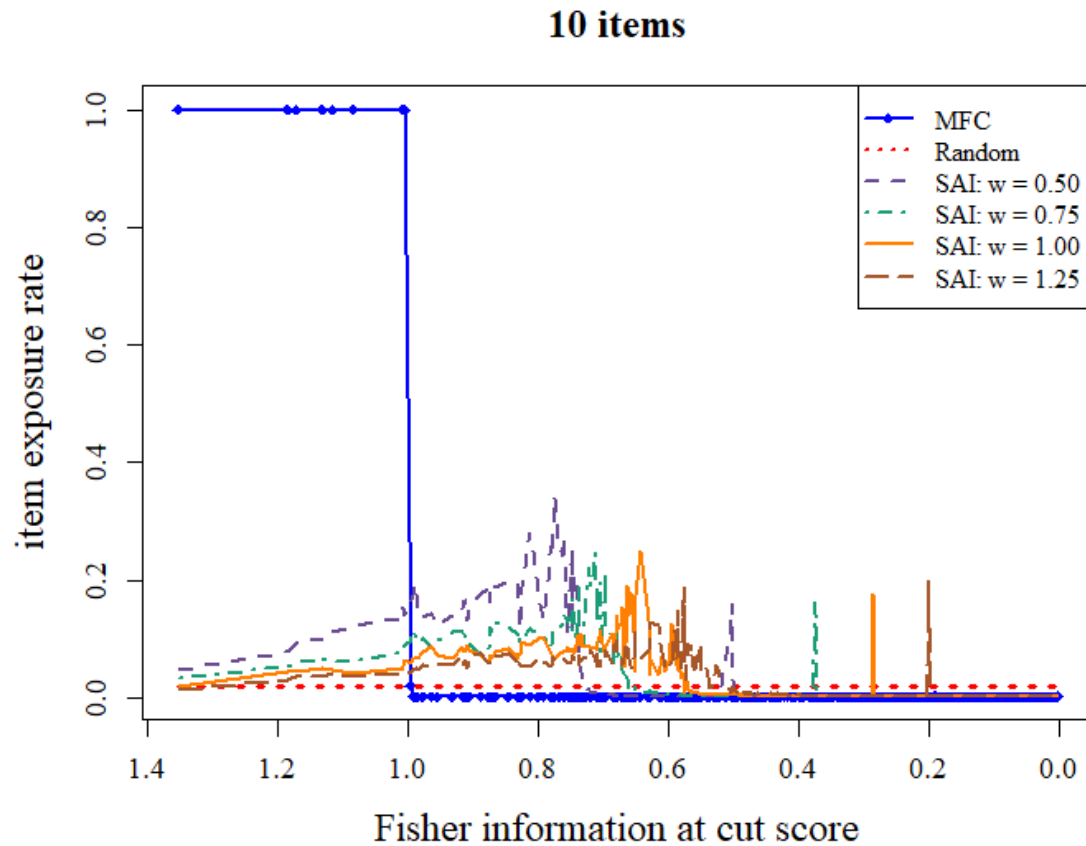
- increase the impact of examinee's speed

- Put forward the timed-SAI method:

$$i_k = \operatorname{argmax}_{j \in R_{k-1}} \frac{SAI}{|E(T_j|\hat{t}_{k-1}) - v|}$$

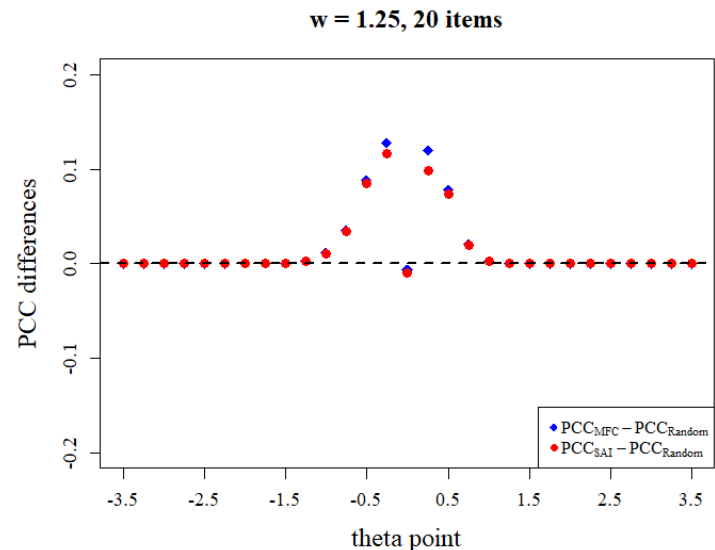
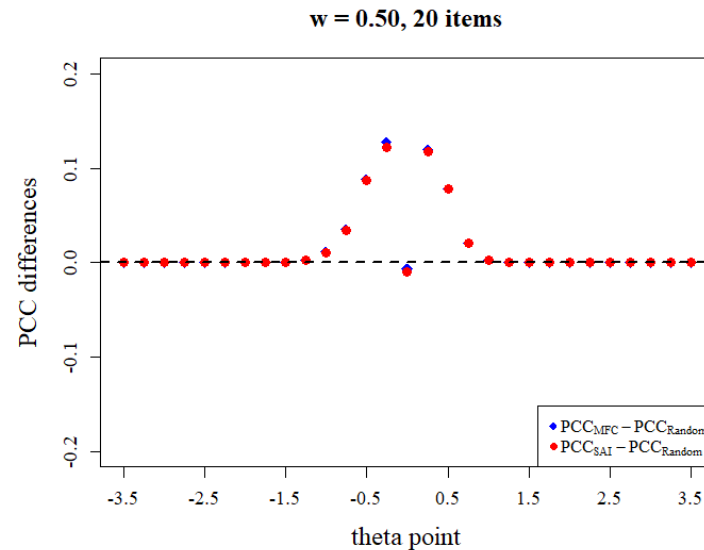
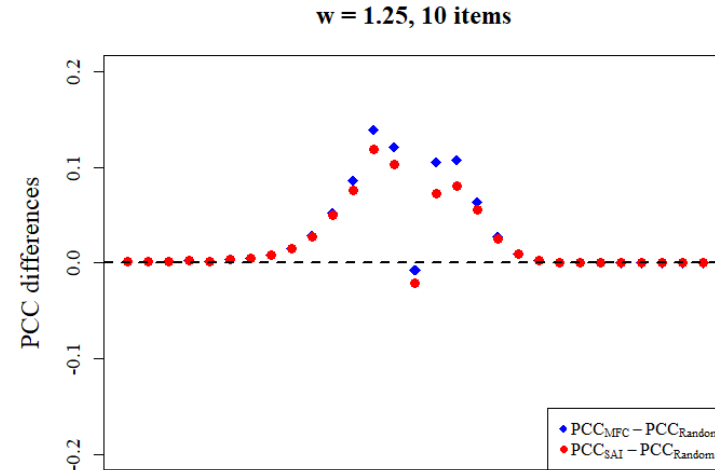
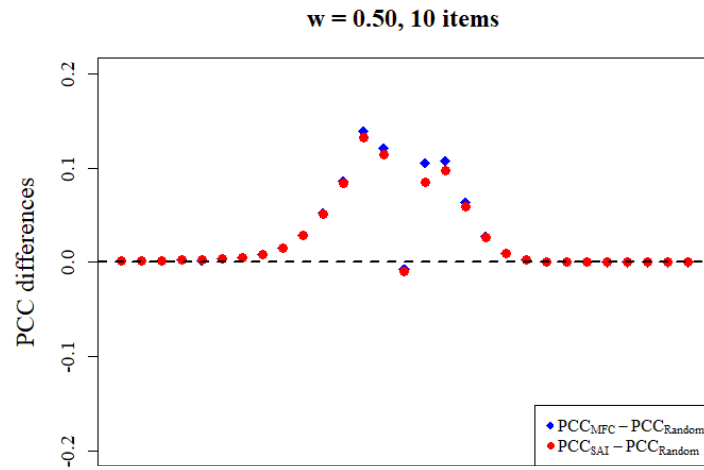
Can SAI counterbalance the item usage?

- ✓ The item exposure rates comparison among the random selection method, MFC, and SAI



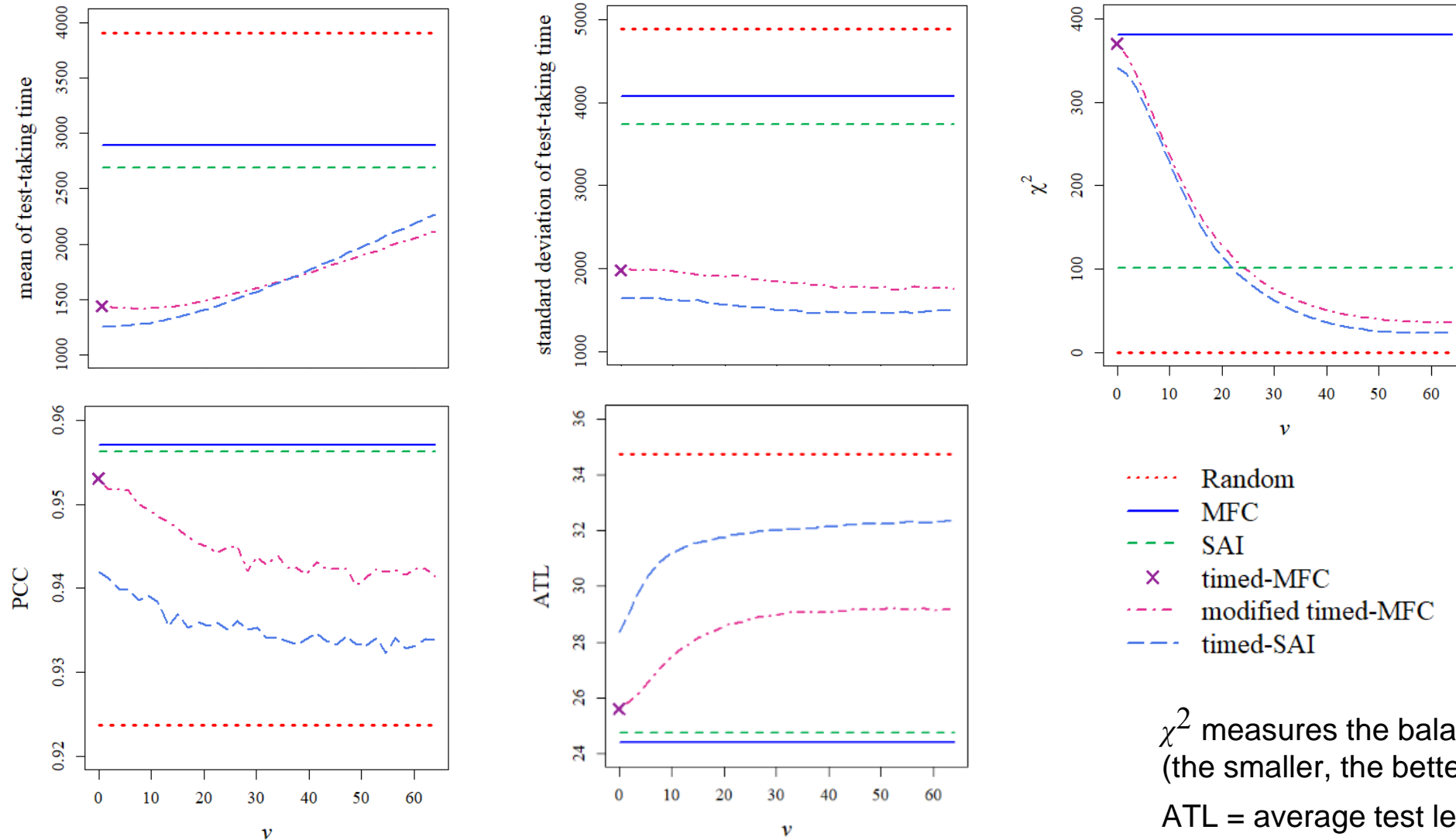
Is the balanced item exposure at a sacrifice of accuracy?

- ✓ The differences in percentage of correct classification (PCC) with the random method as baseline



Can the new timed methods yield short and stable test time?

- ✓ Results of six item selection methods on all evaluation indicators with different ν values



- Can the stage adaptive method yields a balanced item bank usage?
 - Yes, it give items with less information more opportunities to be selected.
- Can the new timed methods shrink the deviation and cost of test-taking time?
 - Yes, the new methods gain the best time control achievement, but they lead to a slight extra cost in accuracy and test length.
- For practitioners:
 - The implementation of SAI:
 - a $w \geq 1$ is recommended for high-stake tests
 - For the two new timed methods:
 - design the v parameter according to the distance between the distribution of β_j and τ

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Thanks for listening!

For any questions, please feel free to contact me:

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